

FORM PTO-1449	U. S DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO.	SERIAL NO.
<p style="text-align: center;">INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use several sheets if necessary)</p> <div style="text-align: right; margin-top: -20px;">  </div>		U 013454-0	09/852,891
		APPLICANT	
		Yaron CASPI, et al.	
		FILING DATE	GROUP
		May 10, 2001	2624
		U.S. PATENT DOCUMENTS	

EXAMINER INITIALS	REFERENCE DESIGNATION	DOCUMENT NUMBER	DATE	NAME	FILING DATE IF APPROPRIATE
/KP/	AA	5,987,164	11/1999	Szeliski, et al.	
	AB				
	AC				
	AD				
	AE				
	AF				
	AG				
	AH				
	AI				
	AJ				
	AK				

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
/KP/	AL	96/15508	05/1996	WO		
	AM					
	AN					
	AO					
	AP					

OTHER ART (Including Author, Title, Date, Pertinent Dates, Etc.)		
	AR	
	AS	
	AT	

EXAMINER	/Kanjibhai Patel/	DATE CONSIDERED	01/16/2008
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Date: February 3, 2004

Page 1 of 1

FORM PTO-1449 (Colb)		ATTY DOCKET NO. U 013454-0	SERIAL NUMBER 09/852,891
LIST OF PATENTS AND PUBLICATIONS FOR APPLICANTS' INFORMATION STATEMENT		APPLICANT Yaron CASPI, et al.	EXAMINER (N/A)
		FILING DATE May 10, 2001	GROUP ART UNIT 2624

U.S. PATENT DOCUMENTS

Examiner's Initials		DOCUMENT NO.	DATE	NAME	CLASS	SUB	FILING DATE
AK	AA	4,720,633	01-1988	Nelson			
	AB	4,880,976	11-1989	Mancuso, et al.			
	AC	5,412,211	05-1995	Knowles			RECEIVED
	AD	5,789,748	08-1998	Liu, et al.			REB 26 2004
	AE	6,459,482	10-2002	Singh, et al.			Technology Center 2600
	AF						
	AG						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB	TRANSLATION
	AH						
	AI						

OTHER ART (Including Author, Bills, Pertinent Pages, Etc.)

	AJ	
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	AL	
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EXAMINER: Carly Parko DATE CONSIDERED: 6/24/04

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				May 10, 2001	
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EXAMINER INITIALS	REFERENCE DESIGNATION	DOCUMENT NUMBER	DATE	NAME	FILING DATE IF APPROPRIATE
/KP/	AA	5,294,978	3/1994	Katayama	
	AB	5,920,657	7/1999	Bender, et al.	
	AC	5,988,863	11/1999	Demos	
	AD	5,798,798	8/1998	Rector, et al.	
↓	AE	5,523,786	6/1996	Parulski	
FOREIGN PATENT DOCUMENTS					
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION
					YES
/KP/	AF	0 551 595 A2	7/1993	EP	X
/KP/	AG	99/37088	7/1999	WO	
OTHER ART (Including Author, Title, Date, Pertinent Dates, Etc.)					
/KP/	AH	Pissinou, N., et al., "A Topological-Directional Model for the Spatio-Temporal Composition of Video Objects", <i>IEEE</i> , Feb. 1998, pages 17-24			
	AI	Tsai, R.Y., et al., "A New Technique for Full Autonomous and Efficient 3D Robotics Hand/Eye Calibration", <i>IEEE Journal of Robotics and Automation</i> , June 1989, pp 345-358			
	AJ	Zisserman, A., et al., "Metric Calibration of A Stereo Rig", <i>Workshop on Representations of Visual Scenes</i> , 1995, pages 93-100			
	AK	Irani, M., et al., "From Reference Frames to Reference Planes: Multi-View Parallax Geometry and Applications", <i>European Conference on Computer Vision, Freiburg</i> , June 1998, 15 pages			
	AL	Shashua, A., et al., "Relative Affine Structure: Theory and Application to 3D Reconstruction from Perspective Views", <i>IEEE Conference on Computer Vision and Pattern Recognition, Seattle WA</i> , June 1994, pages 483-489			
	AM	Hartley, R. I., "In Defence of the 8-point Algorithm", <i>In Pattern Recognition and Machine Intelligence 19</i> , 6 June 1997, pages 580-593			
	AN	Horaud, R., et al., "Hand-Eye Calibration", <i>International Journal of Robotics Research 14(3)</i> , June 1995, pages 195-210 (reprinted 1-28)			
↓	AO	Avidan, S., et al., "Threading Fundamental Matrices", <i>In European conference on Computer Vision</i> , 1998, pp 1-10			
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/KP/	AP	Beardsley, P., et al, "3D Model Acquisition from Extended Image Sequences", <i>In proc 4<sup>th</sup> European Conference on Computer Vision, LNCS 1065, Cambridge, 1996</i> , pages 683-695		
	AQ	Burt, P. J., et al., "Enhanced Image Capture Through Fusion", <i>In International Conference on Computer Vision, 1993</i> , pp 173-182		
	AR	Demirdjian, D. et al., "Stereo Autocalibration From One Plane", <i>In European Conference on Computer Vision, 2000</i> . 15 pages		
	AS	Dufournaud, Y., et al., "Matching Images with Different Resolutions", <i>In IEEE Conference on Computer Vision and Pattern Recognition, Hilton Head Island, South Carolina, June 2000</i> , pp 612-618		
	AT	Haraud, R., et al., "Self-Calibration and Euclidean Reconstruction Using Motions of a Stereo Rig", <i>In International Conference on Computer Vision, 1998</i> , pages 96-103		
	AU	Gantmakher, F.R., "Matrix Equations", <i>Chapter VIII, Chelsea Pub NY, 1959</i> , pp 215-220		
	AV	Golub, G., et al., "3.5 Improving and Estimating Accuracy," <i>Matrix Computations, The John Hopkins University Press, Baltimore and London, 1989</i> , pages 123-127		
↓	AW	Hartley, R., et al., "Estimation - 2D Projective Transformations", <i>MULTIPLE VIEW GEOMETRY IN COMPUTER VISION</i> , Cambridge University Press, Cambridge, 2000, pp 69-116.		
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		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION
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/KP/	AL	2000-76423	14 Mar 2000	JP	<input checked="" type="checkbox"/> X
	AM				
	AN				
	AO				
	AP				

OTHER ART (Including Author, Title, Date, Pertinent Dates, Etc.)		
/KP/	AR	Esp@cenet english Abstract of JP2000076423 dated 14 March 2000
	AS	
	AT	

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